

Pb Lead-free Green

Product Summary

Device	V _{(BR)DSS}	R _{DS(on)}	Ι _D Τ _A = 25°C
Q1	20V	35mΩ @ V _{GS} = 4.5V	4.5A
QT	200	43mΩ @ V _{GS} = 2.5V	4.0A
Q2	-20V	74mΩ @ V _{GS} = -4.5V	
92	-20V	110mΩ @ V _{GS} = -2.5V	-2.6A

Description and Applications

This new generation MOSFET has been designed to minimize the onstate resistance (R_{DS(on)}) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Backlighting
- DC-DC Converters
- Power management functions

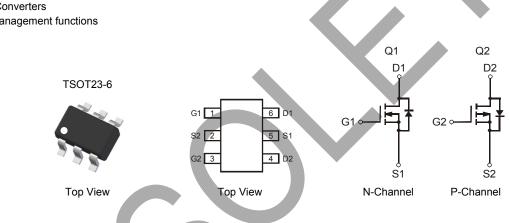
COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Features and Benefits

- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Lead Free By Design/RoHS Compliant (Note 1)
- "Green" Device (Note 2)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: TSOT23-6
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Weight: 0.008 grams (approximate)



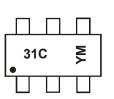
Ordering Information (Note 3)

	1000000		
Part Number		Case	Packaging
DMC3038LVT-7		TSOT23-6	3000 / Tape & Reel
0000000			

1. No purposefully added lead. Notes:

Diodes Inc.'s "Green" policy can be found on our website at http://www.diodes.com.
For packaging details, go to our website at http://www.diodes.com.

Marking Information



31C = Product Type Marking Code YM = Date Code Marking Y = Year (ex: X = 2010) M = Month (ex: 9 = September)

Date	Code	Kev

Year	2010)	2011		2012	20	13	2014		2015	2	2016
Code	Х		Y		Z	A	A	В		С		D
Month	Jan	Feb	Mar	Apr	Мау	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	Ν	D



Maximum Ratings – Q1 @TA = 25°C unless otherwise specified

Characteristic	Characteristic				Unit
Drain-Source Voltage			V _{DSS}	20	V
Gate-Source Voltage			V _{GSS}	±12	V
Continuous Drain Current (Note 4) V_{GS} = 4.5V	Steady State	T _A = 25°C T _A = 70°C	ID	4.6 3.6	A
Continuous Drain Current (Note 4) V_{GS} = 2.5V	Steady State	T _A = 25°C T _A = 70°C	ID	4.0 3.2	А
Pulsed Drain Current (Note 5)		•	I _{DM}	17.0	A

Maximum Ratings - Q2 @TA = 25°C unless otherwise specified

Characteristic			Symbol	Value	Unit
Drain-Source Voltage			V _{DSS}	-20	V
Gate-Source Voltage			V _{GSS}	±12	V
Continuous Drain Current (Note 4) V_{GS} = -4.5V	Steady State	T _A = 25°C T _A = 70°C	l _D	-3.2 -2.6	А
Continuous Drain Current (Note 4) V _{GS} = -2.5V	Steady State	T _A = 25°C T _A = 70°C	ID	-2.6 -2.1	А
Pulsed Drain Current (Note 5)			I _D	-12.0	А

Thermal Characteristics

		 And the second se		
Characteristic		Symbol	Value	Unit
Power Dissipation (Note 4)		PD	1.12	W
Thermal Resistance, Junction to Ambient @T _A = 25°C	(Note 4)	R _{0JA}	111	°C/W
Operating and Storage Temperature Range		T _J , T _{STG}	-55 to +150	°C

Electrical Characteristics – Q1 @ TA = 25°C unless otherwise stated

		1000000	V			
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)						
Drain-Source Breakdown Voltage	BV _{DSS}	20	-	-	V	$V_{GS} = 0V, I_D = 250 \mu A$
Zero Gate Voltage Drain Current	IDSS	-	-	1.0	μΑ	V _{DS} = 16V, V _{GS} = 0V
Gate-Source Leakage	I _{GSS}	-	-	±100	nA	$V_{GS} = \pm 12V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 6)						
Gate Threshold Voltage	V _{GS(th)}	0.4	-	1.0	V	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$
		-	27	35		V _{GS} = 4.5V, I _D = 4.0A
Static Drain-Source On-Resistance	R _{DS (ON)}	-	33	43	mΩ	V _{GS} = 2.5V, I _D = 2.5A
		-	43	56		V _{GS} = 1.8V, I _D = 1.5A
Forward Transfer Admittance	Y _{fs}	-	9	-	S	V _{DS} = 5V, I _D = 3.4A
Diode Forward Voltage	V _{SD}	0.4	-	1.1	V	V _{GS} = 0V, I _S = 1A
DYNAMIC CHARACTERISTICS (Note 7)						
Input Capacitance	Ciss	-	TBD	-		
Output Capacitance	Coss	-	TBD	-	pF	V_{DS} = 10V, V_{GS} = 0V, f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}	-	TBD	-		
Gate Resistance	Rg	-	TBD	-	Ω	V_{DS} = 0V, V_{GS} = 0V, f = 1MHz
Total Gate Charge (V _{GS} = 10V)	Qg	-	TBD	-		V _{DS} = 10V, V _{GS} = 10V, I _D = 4.0A
Total Gate Charge (V _{GS} = 4.5V)	Qg	-	TBD	-	nC	
Gate-Source Charge	Q _{qs}	-	TBD	-	nc	V _{DS} = 10V, V _{GS} = 4.5V, I _D = 4.0A
Gate-Drain Charge	Q _{qd}	-	TBD	-		
Turn-On Delay Time	t _{D(on)}	-	TBD	-		
Turn-On Rise Time	tr	-	TBD	-		V _{GS} = 4.5V, V _{DS} = 10V,
Turn-Off Delay Time	t _{D(off)}	-	TBD	-	ns	$R_G = 6\Omega, R_L = 10\Omega$
Turn-Off Fall Time	tf	-	TBD	-		
Body Diode Reverse Recovery Time	trr	-	TBD	-	ns	I _F = 4.0A, dl/dt = 100A/µs
Body Diode Reverse Recovery Charge	Q _{rr}	-	TBD	-	ns	I _F = 4.0A, dl/dt = 100A/μs

Notes: 4. Device mounted on FR-4 with minimum recommended pad layout, single sided.

Repetitive rating, pulse width limited by junction temperature.
Short duration pulse test used to minimize self-heating effect.

7. Guaranteed by design. Not subject to production testing.

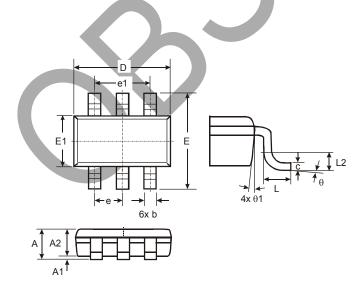


- -

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 6)						·
Drain-Source Breakdown Voltage	BV _{DSS}	-20	-	-	V	V _{GS} = 0V, I _D = -250μA
Zero Gate Voltage Drain Current	I _{DSS}	-	-	-1.0	μA	V _{DS} = -16V, V _{GS} = 0V
Gate-Source Leakage	I _{GSS}	-	-	±100	nA	$V_{GS} = \pm 12V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 6)						
Gate Threshold Voltage	V _{GS(th)}	-0.4	-	-1.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
		-	57	74		V_{GS} = -4.5V, I_{D} = -3.0A
Static Drain-Source On-Resistance	R _{DS (ON)}	-	76	110	mΩ	V _{GS} = -2.5V, I _D = -1.5A
		-	102	168		$V_{GS} = -1.8V, I_D = -1.0A$
Forward Transfer Admittance	Y _{fs}	-	10	-	S	$V_{DS} = -5V, I_D = -3.0A$
Diode Forward Voltage	V _{SD}	-	-0.8	-1.0	V	$V_{GS} = 0V, I_{S} = -0.6A$
DYNAMIC CHARACTERISTICS (Note 7)						
Input Capacitance	Ciss	-	TBD	-		
Output Capacitance	Coss	-	TBD	—	pF	V _{DS} = -10V, V _{GS} = 0V, f = 1.0MHz
Reverse Transfer Capacitance	C _{rss}	-	TBD	-		
Gate Resistance	Rg	-	TBD	-	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1MHz$
Total Gate Charge (V _{GS} = 10V)	Qg	-	TBD			V _{DS} = -10V, V _{GS} = -10V, I _D = -2.5/
Total Gate Charge (V _{GS} = 4.5V)	Qg	-	TBD	-	nC	
Gate-Source Charge	Q _{gs}	-	TBD	-		V _{DS} = -10V, V _{GS} = -4.5V, I _D = -2.5
Gate-Drain Charge	Q _{gd}	-	TBD	-		
Turn-On Delay Time	t _{D(on)}	-	TBD	-		
Turn-On Rise Time	tr	-	TBD	-	ns	V _{GS} = -4.5V, V _{DS} = -10V,
Turn-Off Delay Time	t _{D(off)}	-	TBD		115	$R_G = 6\Omega, R_L = 10\Omega$
Turn-Off Fall Time	tf	-	TBD	-		
Body Diode Reverse Recovery Time	trr	-	TBD	-	ns	I _F = -3.0A, dl/dt = 100A/μs
Body Diode Reverse Recovery Charge	Qrr	-	TBD	-	ns	$I_F = -3.0A$, dl/dt = 100A/µs

6. Short duration pulse test used to minimize self-heating effect.7. Guaranteed by design. Not subject to production testing.

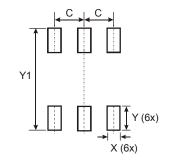
Package Outline Dimensions



	TSOT	23-6	
Dim	Min	Max	Тур
Α	-	1.00	1
A1	0.01	0.10	-
A2	0.84	0.90	-
D	-	-	2.90
Е	_	-	2.80
E1	-	-	1.60
b	0.30	0.45	-
С	0.12	0.20	-
е	-	-	0.95
e1	-	-	1.90
L	0.30	0.50	
L2	_	_	0.25
θ	0°	8°	4°
θ1	4°	12°	_
All D	imensi	ons in	mm



Suggested Pad Layout



Dimensions	Value (in mm)
С	0.950
Х	0.700
Y	1.000
Y1	3.199

IMPORTANT NOTICE

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel. Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

- A. Life support devices or systems are devices or systems which:
 - 1. are intended to implant into the body, or
 - 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2011, Diodes Incorporated

www.diodes.com